

# N-Channel MOSFET

# **Applications:**

- Adaptor
- .Charger
- .SMPS

#### Features:

- RoHS Compliant
- . Low ON Resistance
- .Low Gate Charge
- •Peak Current vs Pulse Width Curve
- Inductive Switching Curves

# Ordering Information

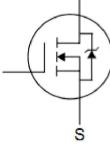
650V	1.2Ω	7A
		D
-	G	
Dealara		$\sim$

R<sub>DS(ON)</sub>(Typ.)

Packages Not to Scale

Pb

 $V_{DSS}$ 



 $I_{D}$ 

Ordening information							
PART NUMBER	PACKAGE	BRAND					
ITD07N65R	TO-252	IPS					

#### Absolute Maximum Ratings

## $T_C=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	ITD07N65R	Units
V <sub>DSS</sub>	Drain-to-Source Voltage	650	V
I <sub>D</sub>	Continuous Drain Current	7	Α
I <sub>DM</sub>	Pulsed Drain Current, V <sub>GS</sub> @10V (NOTE *2)	28	Α
D	Power Dissipation	100	W
P <sub>D</sub>	Derating Factor above 25℃	0.8	W/℃
V <sub>GS</sub>	Gate-to-Source Voltage	±30	V
E <sub>AS</sub>	Single Pulse Avalanche Energy (L=10mH)	350	mJ
TL	Maximum Temperature for Soldering	300	
$T_{\rm J}$ and $T_{\rm STG}$	Operating Junction and Storage Temperature Range (NOTE *1)	150,-55 to150	°C

#### **Thermal Resistance**

Symbol	Parameter	Тур.	Units	Test Conditions
Б	Junction-to-Case	1.25		Water cooled heatsink, $P_{D}$ adjusted for a
$R_{ extsf{ heta}JC}$	Junction-to-Case	1.25	°C <b>/W</b>	peak junction temperature of +150 $^\circ\!\!{ m C}$ .
R <sub>0JA</sub>	Junction-to-Ambient	100		1 cubic foot chamber, free air.

©2015 InPower Semiconductor Co., Ltd.



Lead Free Package and Finish



#### **OFF Characteristics** $T_C=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BV <sub>DSS</sub>	Drain-to-Source Breakdown Voltage	650			V	V <sub>GS</sub> =0V, I <sub>D</sub> =250µA
				1		$V_{DS}$ =650V, $V_{GS}$ =0V
	Drain-to-Source Leakage Current			I	μA	T <b>J=25</b> ℃
IDSS				- 100		$V_{DS}$ =520V, $V_{GS}$ =0V
						T <b>」=125</b> ℃
1	Gate-to-Source Forward Leakage Gate-to-Source Reverse Leakage			+100	nA	$V_{GS}$ =+30V
I <sub>GSS</sub>				-100	ПА	V <sub>GS</sub> = -30V

**ON Characteristics**  $T_J=25^{\circ}C$  unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Р	StaticDrain-to-Source		10	1 1	0	V <sub>GS</sub> =10V, I <sub>D</sub> =3.5A
R <sub>DS(ON)</sub>	On-Resistance(NOTE *3)		1.2	1.4	Ω	
V <sub>GS(TH)</sub>	Gate Threshold Voltage	2		4	V	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =250µA
9 <sub>fs</sub>	Forward Transconductance(NOTE *3)		6.5		S	V <sub>DS</sub> =15V, I <sub>D</sub> =3.5A

Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
C <sub>iss</sub>	Input Capacitance		1130			(1 - 0)(1)(-2E)(
C <sub>oss</sub>	Output Capacitance		93		pF	$V_{GS}$ = 0V, $V_{DS}$ = 25V f =1.0MHz
C <sub>rss</sub>	Reverse Transfer Capacitance		5.5			1 - 1.010112
Qg	Total Gate Charge		24			
Q <sub>gs</sub>	Gate-to-Source Charge		5.1		nC	I <sub>D</sub> =7A,V <sub>DD</sub> =520V V <sub>GS</sub> = 10V
$Q_{gd}$	Gate-to-Drain ("Miller") Charge		9.5			v <sub>GS</sub> – 10V

## Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	<b>Test Conditions</b>
t <sub>d(ON)</sub>	Turn-on Delay Time		19			
t <sub>rise</sub>	Rise Time		21			V <sub>DD</sub> =325V, I <sub>D</sub> =7A,
t <sub>d(OFF)</sub>	Turn-Off Delay Time		42		ns	$V_G$ =10V $R_G$ =10 $\Omega$
t <sub>fall</sub>	Fall Time		19			

©2015 InPower Semiconductor Co., Ltd.



	Source-Drain	<b>Diode Characteristics</b>	Tc=2
--	--------------	------------------------------	------

Tc=25℃ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ŀ	Continuous Source Current			7	А	
IS	(Body Diode)				A	T <sub>C</sub> =25℃
1	Maximum Pulsed Current			28	А	1 <sub>C</sub> -25 C
I <sub>SM</sub>	(Body Diode)			20	A	
V <sub>SD</sub>	Diode Forward Voltage			1.5	V	I <sub>SD</sub> =7A, V <sub>GS</sub> =0V
t <sub>rr</sub>	Reverse Recovery Time		382		ns	I <sub>F</sub> = I <sub>S</sub>
Q <sub>rr</sub>	Reverse Recovery Charge		1980		nC	di/dt=100A/us

Notes:

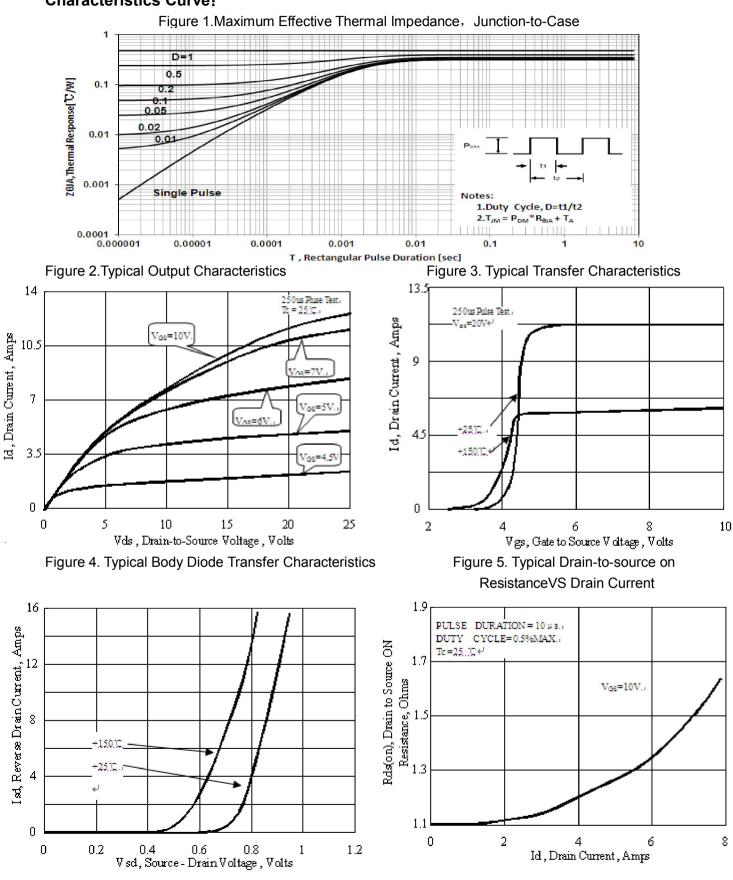
\*1. T<sub>J</sub> = +25  $^\circ \rm C$  to +150  $^\circ \rm C$  .

\*2. Repetitive rating; pulse width limited by maximum junction temperature.

\*3. Pulse width <  $380\mu$ s; duty cycle < 2%.



#### **Characteristics Curve:**



©2015 InPower Semiconductor Co., Ltd.



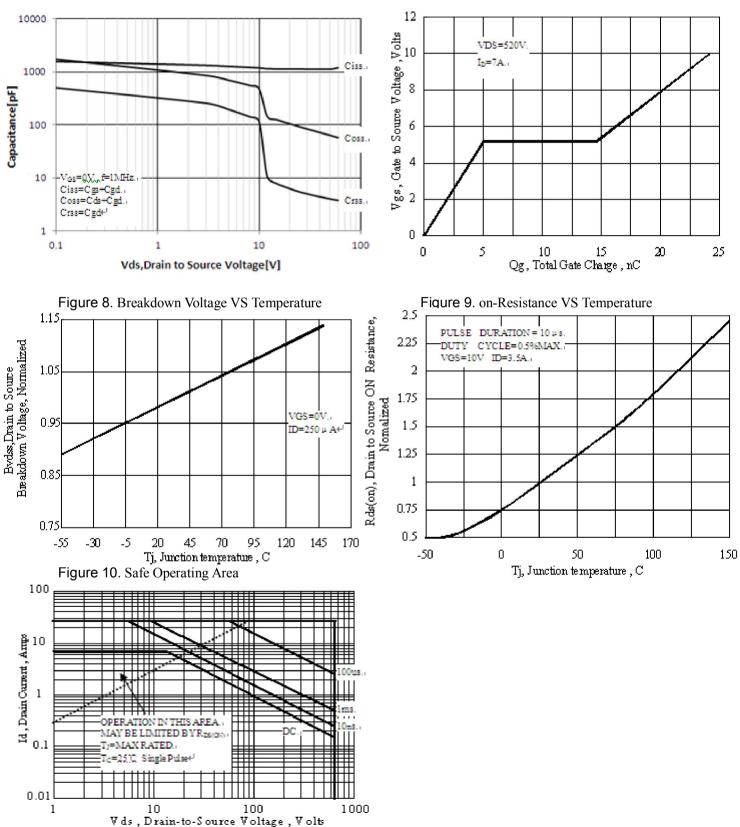


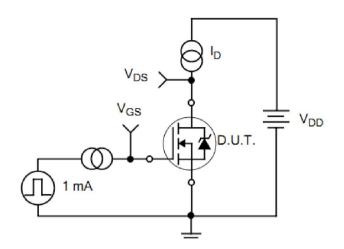
Figure 6. Capacitance VS Drain-to-Source Voltage

Figure 7. Gate Charge VS Gate-to-Source Voltage



ITD07N65R

# **Test Circuits and Waveforms**



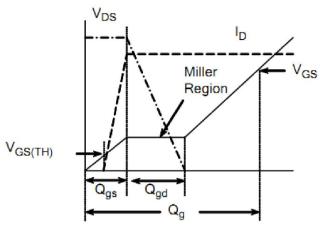
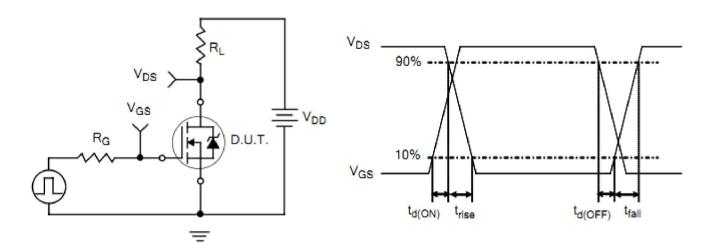
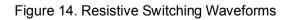


Figure 11. Gate Charge Test Circuit

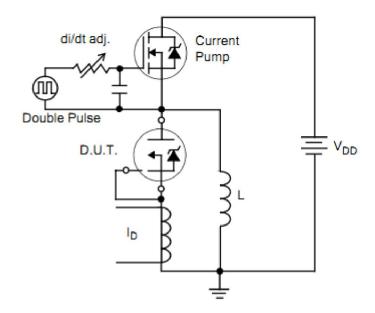
Figure 12. Gate Charge Waveforms











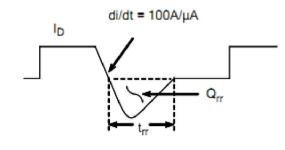


Figure 15. Diode Reverse Recovery Test Circuit

Figure 16. Diode Reverse Recovery Waveform

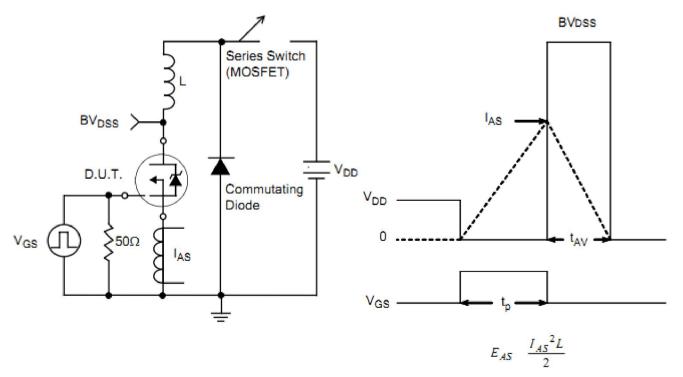


Figure 17. Unclamped Inductive Switching Test Circuit Figure 18. Unclamped Inductive Switching Waveform



# **Disclaimers:**

InPower Semiconductor Co., Ltd (IPS) reserves the right to make changes without notice in order to improve reliability, function or design and to discontinue any product or service without notice. Customers should obtain the latest relevant information before orders and should verify that such information is current and complete. All products are sold subject to IPS's terms and conditions supplied at the time of order acknowledgement.

InPower Semiconductor Co., Ltd warrants performance of its hardware products to the specifications at the time of sale, Testing reliability and quality control are used to the extent IPS deems necessary to support this warrantee. Except where agreed upon by contractual agreement, testing of all parameters of each product is not necessarily performed.

InPower Semiconductor Co., Ltd does not assume any liability arising from the use of any product or circuit designs described herein. Customers are responsible for their products and applications using IPS's components. To minimize risk, customers must provide adequate design and operating safeguards.

InPower Semiconductor Co., Ltd does not warrant or convey any license either expressed or implied under its patent rights, nor the rights of others. Reproduction of information in IPS's data sheets or data books is permissible only if reproduction is without modification or alteration. Reproduction of this information with any alteration is an unfair and deceptive business practice. InPower Semiconductor Co., Ltd is not responsible or liable for such altered documentation.

Resale of IPS's products with statements different from or beyond the parameters stated by InPower Semiconductor Co., Ltd for that product or service voids all express or implied warrantees for the associated IPS's product or service and is unfair and deceptive business practice. InPower Semiconductor Co., Ltd is not responsible or liable for any such statements.

### Life Support Policy:

InPower Semiconductor Co., Ltd's products are not authorized for use as critical components in life support devices or systems without the expressed written approval of InPower Semiconductor Co., Ltd.

As used herein:

- 1. Life support devices or systems are devices or systems which:
  - a. are intended for surgical implant into the human body,
  - b. support or sustain life,
  - c. whose failure to perform when properly used in accordance with instructions for used provided in the labeling, can be reasonably expected to result in significant injury to the user.

2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.